Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/829,210	CHEN, YI-JEN	
Examiner	Art Unit	
Khiem Nguyen	2839	

SEARCHED					
Class	Subclass	Date	Examiner		
То	Date	2/2/2006	KN		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
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